



## MJE13003

## NPN EPITAXIAL SILICON TRANSISTOR

### NPN SILICON POWER TRANSISTORS

#### DESCRIPTION

These devices are designed for high-voltage, high-speed power switching inductive circuits where fall time is critical. They are particularly suited for 115 and 220V SWITCHMODE .

#### FEATURES

- \* Reverse Biased SOA with Inductive Load @  $T_c=100^\circ\text{C}$
- \* Inductive Switching Matrix 0.5 ~ 1.5 Amp, 25 and  $100^\circ\text{C}$   
Typical  $t_c = 290\text{ns}$  @ 1A,  $100^\circ\text{C}$ .
- \* 700V Blocking Capability

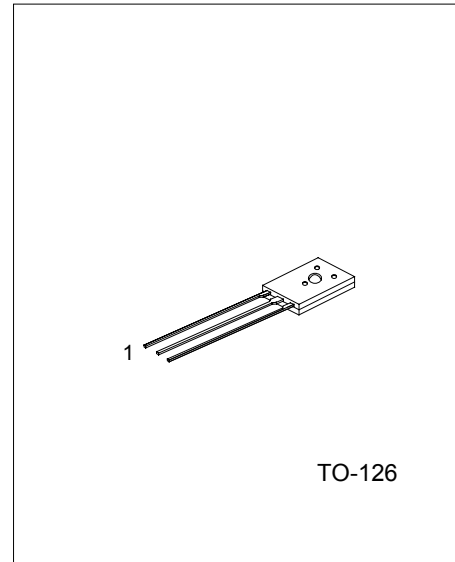
#### APPLICATIONS

- \* Switching Regulator's, Inverters
- \* Motor Controls
- \* Solenoid/Relay drivers
- \* Deflection circuits

#### ORDERING INFORMATION

Order Number		Package	Pin Assignment			Packing
Normal	Lead Free Plating		1	2	3	
MJE13003-x-T60-F-K	MJE13003L-x-T60-F-K	TO-126	B	C	E	Bulk

Note: x: Rank, refer to Classification of  $h_{FE1}$ .



\*Pb-free plating product number: MJE13003L

<p>MJE13003L-x-T60-F-K</p>	<p>(1)K: Bulk  (2) refer to Pin Assignment  (3) T60: TO-126  (4) x: refer to Classification of <math>h_{FE1}</math>  (5) L: Lead Free Plating, Blank: Pb/Sn</p>
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## ■ ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	RATINGS	UNIT
Collector-Emitter Voltage	$V_{CEO(SUS)}$	400	V
Collector-Emitter Voltage	$V_{CEO}$	700	V
Emitter Base Voltage	$V_{EBO}$	9	V
Collector Current	Continuous	$I_C$	1.5
	Peak (1)	$I_{CM}$	3
Base Current	Continuous	$I_B$	0.75
	Peak (1)	$I_{BM}$	1.5
Emitter Current	Continuous	$I_E$	2.25
	Peak (1)	$I_{EM}$	4.5
Total Power Dissipation ( $T_C=25^\circ C$ )	$P_D$	40	W
Junction Temperature	$T_J$	150	$^\circ C$
Storage Temperature	$T_{STG}$	-40 ~ +150	$^\circ C$

Note Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

## ■ ELECTRICAL CHARACTERISTICS ( $T_C=25^\circ C$ , unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS (Note)</b>						
Collector-Emitter Sustaining Voltage	$V_{CEO(SUS)}$	$I_C=10\text{ mA}, I_B=0$	400			V
Collector Cutoff Current	$I_{CEO}$	$V_{CEO}=\text{Rated Value}, V_{BE(OFF)}=1.5\text{ V}$	$T_C=25^\circ C$		1	mA
			$T_C=100^\circ C$		5	
Emitter Cutoff Current	$I_{EBO}$	$V_{EB}=9\text{ V}, I_C=0$			1	mA
<b>SECOND BREAKDOWN</b>						
Second Breakdown Collector Current with base forward biased	$I_{s/b}$		See Figure 5			
Clamped Inductive SOA with base reverse biased	RBSOA		See Figure 6			
<b>ON CHARACTERISTICS (Note)</b>						
DC Current Gain	$h_{FE1}$	$I_C=0.5\text{ A}, V_{CE}=10\text{ V}$	8		40	
	$h_{FE2}$	$I_C=1\text{ A}, V_{CE}=2\text{ V}$	5		25	
Collector-Emitter Saturation Voltage	$V_{CE(SAT)}$	$I_C=0.5\text{ A}, I_B=0.1\text{ A}$			0.5	V
		$I_C=1\text{ A}, I_B=0.25\text{ A}$			1	
		$I_C=1.5\text{ A}, I_B=0.5\text{ A}$			3	
		$I_C=1\text{ A}, I_B=0.25\text{ A}, T_C=100$			1	
Base-Emitter Saturation Voltage	$V_{BE(SAT)}$	$I_C=0.5\text{ A}, I_B=0.1\text{ A}$			1	V
		$I_C=1\text{ A}, I_B=0.25\text{ A}$			1.2	
		$I_C=1\text{ A}, I_B=0.25\text{ A}, T_C=100^\circ C$			1.1	
<b>DYNAMIC CHARACTERISTICS</b>						
Current-Gain-Bandwidth Product	$f_T$	$I_C=100\text{ mA}, V_{CE}=10\text{ V}, f=1\text{ MHz}$	4	10		MHz
Output Capacitance	$C_{ob}$	$V_{CB}=10\text{ V}, I_E=0, f=0.1\text{ MHz}$		21		pF
<b>SWITCHING CHARACTERISTICS</b>						
<b>Resistive Load (Table 1)</b>						
Delay Time	$t_D$	$V_{CC}=125\text{ V}, I_C=1\text{ A}, I_{B1}=I_{B2}=0.2\text{ A}, t_P=25\ \mu\text{ s}, \text{Duty Cycle } 1\%$		0.05	0.1	$\mu\text{ s}$
Rise Time	$t_R$			0.5	1	$\mu\text{ s}$
Storage Time	$t_S$			2	4	$\mu\text{ s}$
Fall Time	$t_{FALL}$			0.4	0.7	$\mu\text{ s}$
<b>Inductive Load, Clamped (Table 1)</b>						
Storage Time	$t_{SV}$	$I_C=1\text{ A}, V_{clamp}=300\text{ V}, I_{B1}=0.2\text{ A}, V_{BE(OFF)}=5\text{ Vdc}, T_C=100^\circ C$		1.7	4	$\mu\text{ s}$
Crossover Time	$t_C$			0.29	0.75	$\mu\text{ s}$
Fall Time	$t_{FALL}$			0.15		$\mu\text{ s}$

Note: Pulse Test :  $PW=300\ \mu\text{ s}$ , Duty Cycle 2%

■ CLASSIFICATION OF  $h_{FE1}$

RANK	A	B	C	D	E	F
RANGE	8 ~ 16	15 ~ 21	20 ~ 26	25 ~ 31	30 ~ 36	35 ~ 40

Table 1. Test Conditions for Dynamic Performance

Reverse Bias Safe Operating Area and Inductive Switching		Resistive Switching
Test Circuits	<p>DUTY CYCLE <math>\leq 10\%</math> <math>t_r, t_f \leq 10ns</math></p> <p>NOTE Pw and Vcc Adjusted for Desired Ic Rs Adjusted for Desired Ib1</p>	
Circuit Values	<p>Coil Data : GAP for 30 mH/2 A Lcoil=50mH</p> <p><math>V_{CC}=20V</math> Ferroxcube core #6656 Vclamp=300V Full Bobbin ( ~ 200 Turns) #20</p>	<p><math>V_{CC}=125V</math> <math>R_C=125\Omega</math> D1=1N5820 or Equiv. <math>R_C=47\Omega</math></p>
Test Waveforms	<p>Output Waveforms</p> <p><math>t_1</math> Adjusted to Obtain Ic</p> $t_1 = \frac{L_{coil}(I_{cpk})}{V_{CC}}$ $t_2 = \frac{L_{coil}(I_{cpk})}{V_{clamp}}$	<p>Test Equipment Scope-Tektronics 475 or Equivalent</p> <p><math>t_r, t_f &lt; 10ns</math> Duty Cycle=1.0% <math>R_s</math> and <math>R_c</math> adjusted for desired <math>I_b</math> and <math>I_c</math></p>

Figure 1. Inductive Switching Measurements

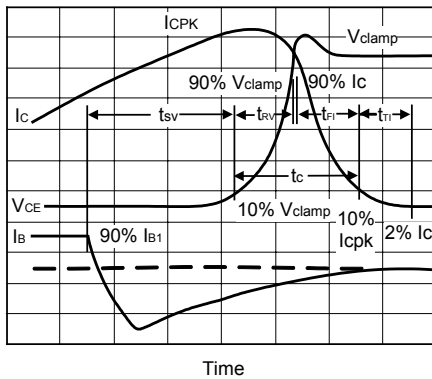


Table 2. Typical Inductive Switching Performance

$I_c$ AMP	$T_c$ $^{\circ}C$	$t_{sv}$ $\mu s$	$t_{rv}$ $\mu s$	$t_{F1}$ $\mu s$	$t_{F1}$ $\mu s$	$t_c$ $\mu s$
0.5	25	1.3	0.23	0.30	0.35	0.30
	100	1.6	0.26	0.30	0.40	0.36
1	25	1.5	0.10	0.14	0.05	0.16
	100	1.7	0.13	0.26	0.06	0.29
1.5	25	1.8	0.07	0.10	0.05	0.16
	100	3	0.08	0.22	0.08	0.28

NOTE: All Data Recorded in the Inductive Switching Circuit in Table 1

## SWITCHING TIMES NOTE

In resistive switching circuits, rise, fall, and storage times have been defined and apply to both current and voltage waveforms since they are in phase. However, for inductive loads, which are common to SWITCHMODE power supplies and hammer drivers, current and voltage waveforms are not in phase. Therefore, separate measurements must be made on each waveform to determine the total switching time. For this reason, the following new terms have been defined.

- $t_{SV}$  = Voltage Storage Time, 90%  $I_{B1}$  to 10%  $V_{clamp}$
- $t_{RV}$  = Voltage Rise Time, 10 ~ 90%  $V_{clamp}$
- $t_{FI}$  = Current Fall Time, 90 ~ 10%  $I_C$
- $t_{TI}$  = Current Tail, 10 ~ 2%  $I_C$
- $t_C$  = Crossover Time, 10%  $V_{clamp}$  to 10%  $I_C$

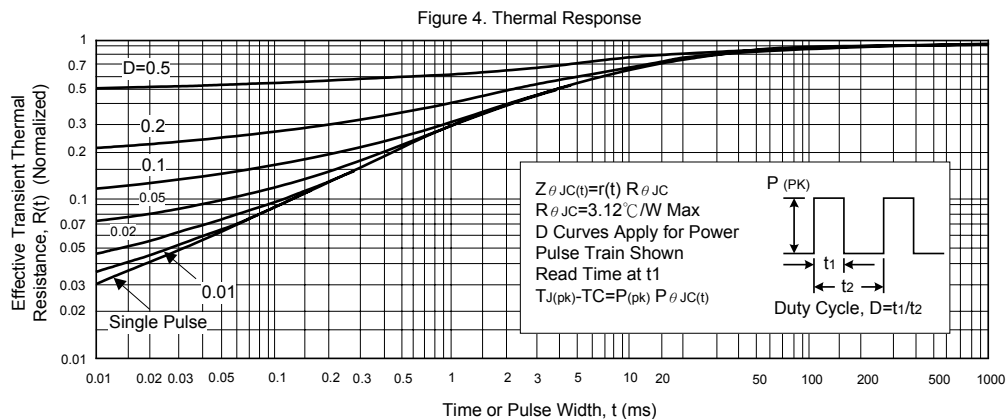
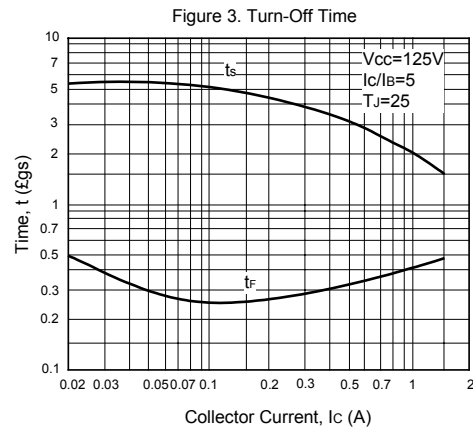
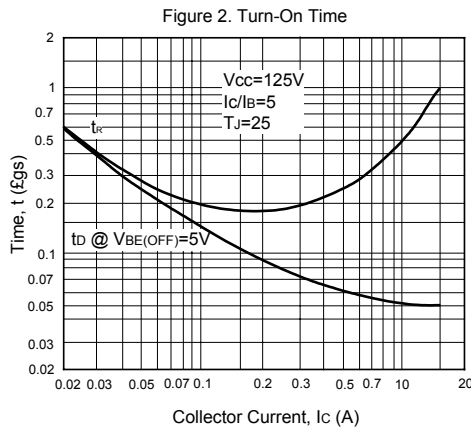
For the designer, there is minimal switching loss during storage time and the predominant switching power losses occur during the crossover interval and can be obtained using the standard equation from AN-222:

$$PSWT = 1/2 V_{CC} I_C (t_C) f$$

In general,  $t_{RV} + t_{FI} \approx t_C$ . However, at lower test currents this relationship may not be valid.

As is common with most switching transistors, resistive switching is specified at 25°C and has become a benchmark for designers. However, for designers of high frequency converter circuits, the user oriented specifications which make this a "SWITCHMODE" transistor are the inductive switching speeds ( $t_C$  and  $t_{SV}$ ) which are guaranteed at 100°C.

## RESISTIVE SWITCHING PERFORMANCE



## ■ SAFE OPERATING AREA INFORMATION

### FORWARD BIAS

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_C$ - $V_{CE}$  limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

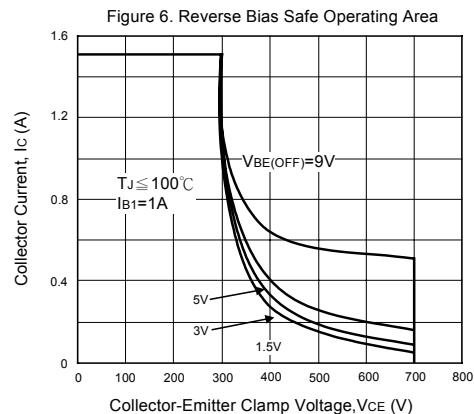
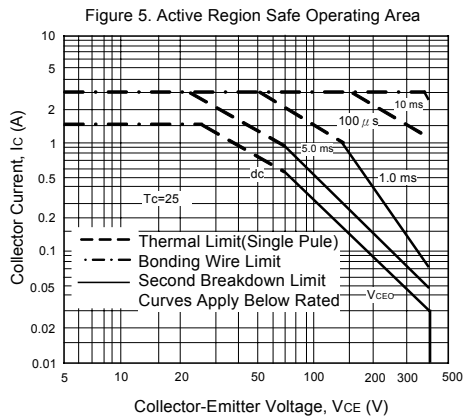
The data of Figure 5 is based on  $T_C = 25^\circ\text{C}$ ;  $T_{J(PK)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C \geq 25^\circ\text{C}$ . Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 5.

$T_{J(PK)}$  may be calculated from the data in Figure 4. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

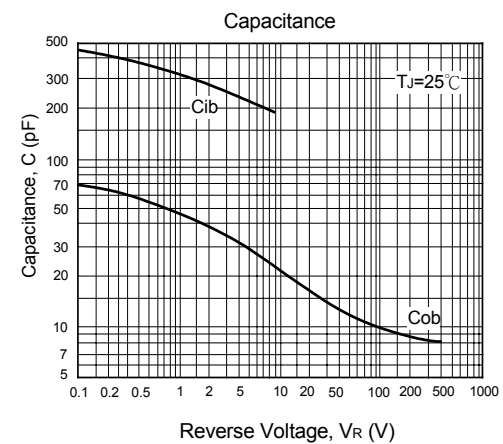
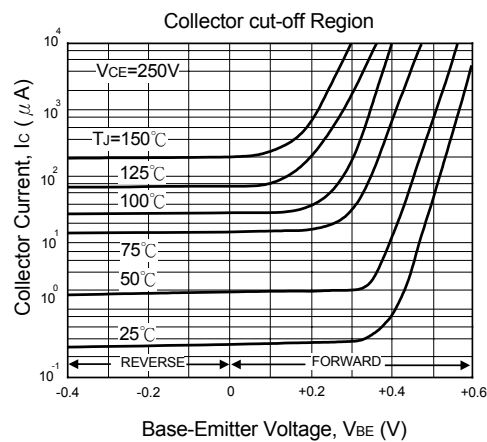
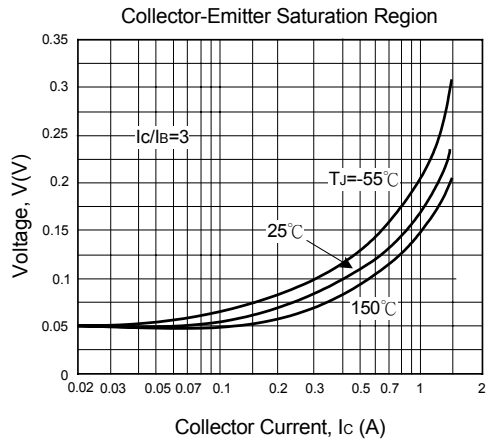
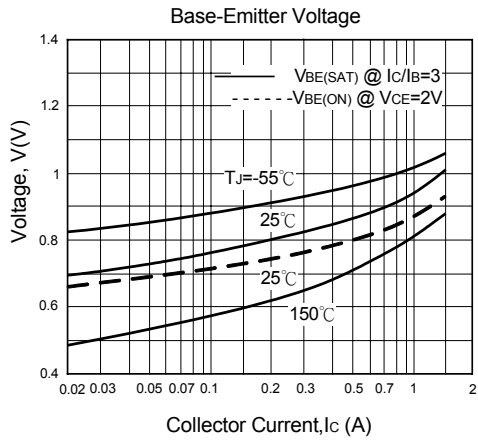
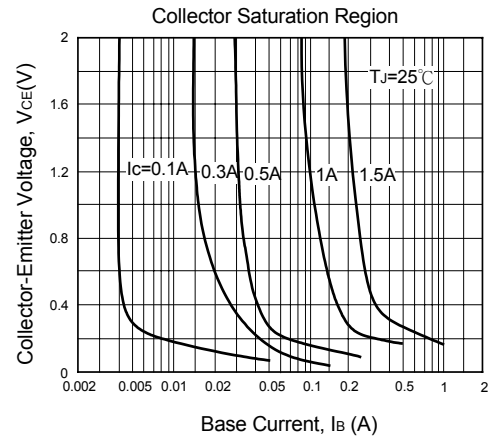
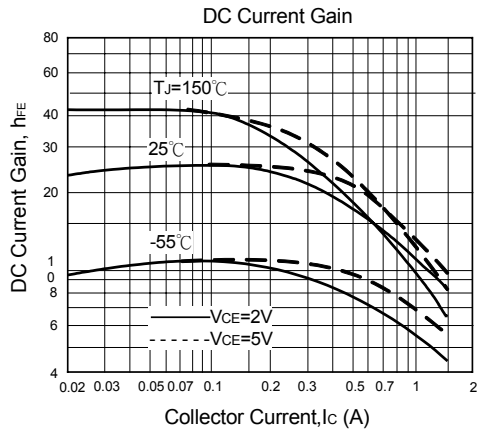
### REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage-current conditions during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 6 gives PBSOA characteristics.

The Safe Operating Area of Figures 5 and 6 are specified ratings (for these devices under the test conditions shown.)



## TYPICAL PERFORMANCE CHARACTERISTICS



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